



Influence of Copper Doping on Structural, Morphological, Electrical Properties of WO₃ Nanoparticles

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ABSTRACT

In this work, Pure and Cu-doped WO₃ nanoparticles have been synthesized using the wet chemical method. The effect of Cu-doping on the structural, morphological, electrical and dielectric properties of WO₃ nanoparticles was investigated. XRD pattern described that Cu-doping without affecting the monoclinic structure of the samples and the few peaks corresponding to Cu, it conforms secondary phase. The presence of more distortion centers and interstitials in Cu-doped sample led to increasing the crystallite size. FESEM analysis has shown the morphology of doped and pure WO₃ nanoparticles to be quasi-spherical. EDAX spectra confirmed the presence of W, O and Cu. The DC and AC conductivity have been measured at a temperature range from 303-403K in the frequency range of 42Hz-5MHz. The DC conductivity was found to increase with increasing Cu and indicates the semiconducting nature. The activation energy has also been observed to decrease with Cu doping. The DC conductivity of the present samples follows small polaron hopping. The frequency dependence of dielectric constant (ϵ'), dielectric loss ($\tan \delta$) and AC conductivity of WO₃ nanoparticles of different Cu doping concentration at different temperature was measured. Temperature variation of frequency exponents in 15 wt% Cu-doped WO₃ suggests that AC conduction is attributed to be correlated barrier hopping.

Keywords: Cu-doped WO₃; Dielectric study; Electrical conductivity; FESEM; XRD.

1. INTRODUCTION

Tungsten oxide (WO₃) is one of the most important transition metal oxide n-type semiconductors with a bandgap of 2.7 eV. It has many excellent properties, such as non-toxic, cheap, unique optical and electrical properties, which has a wide range of applications in the field of the sensor, smart windows, electrochromic, photocatalysts and photodetector (Wen Zeng *et al.* 2014; Georg *et al.* 2008; Danineet *et al.* 2014; Changhua *et al.* 2014; Zhiyang He *et al.* 2015). A number of methods have been employed for doped transition metal oxide nanoparticles with different sizes and shapes, such as colloidal chemical, template, RF thermal plasma, sol-gel, screen printing, chemical co-precipitation (Huijuan Xia *et al.* 2008; Hui Song *et al.* 2015; Mingshui Yao *et al.* 2015; Somayeh Fardindoost *et al.* 2010; Hubaleket *et al.* 2004; Upadhyayet *et al.* 2014) and so on. Among these methods, the wet chemical method seems to be a versatile, low-cost, and environmentally friendly method for preparing WO₃ nanostructures. To date, properties of WO₃ can be tuned according to the research interest by doping with various metal atoms to proper pre-determined needs and applications (Wang *et al.* 2007). The metal dopant induces a significant modification in the optical and electrical properties of

WO₃. Numerous researchers have reported the changes induced by the incorporation of transition metal ions into WO₃ lattice (Huijuan Xia *et al.* 2008; Kuzminet *et al.* 2014; Ahsan *et al.* 2012; Cholsong Pang *et al.* 2010; Gauryet *et al.* 2013).

In the few decades, the number of reports on transition metal doped WO₃ system, very fewer work is done on Cu-doped WO₃. The main reason for choosing dopant Cu to act as an electron receptor offers electrons to the WO₃ conduction band and changes the electronic structure and carrier concentration of the metal oxide. Particularly, Cu is an equivalent substance in WO₃ and so far enhances electrical conductivity (Wang, 2011). For example, the doping of Cu occupies the atomic sites instead of interstitial sites of the WO₃ lattice. Therefore, Cu incorporation WO₃ photonic crystal structure exhibit enhanced sensitivity to TMA (to check the freshness of fish) compared with the pure WO₃ (Shenmin Zhu *et al.* 2010). The Cu-doped WO₃ found that the sensing properties of acetone gas have been significantly improved compared with undoped WO₃ (Hao Zhou *et al.* 2015).

Many researchers have been interested investigate the dielectric properties of WO₃ and AC measurements, which is an important tool for studying

properties like dielectric constant, dielectric loss tangent, capacitance and semiconducting dielectric materials (El-Nahass *et al.* 2012; Hutchins *et al.* 2007). This measurement gives information about the interior of the material. Besides, a given material dielectric properties strongly depend on the preparation conditions. Therefore, the present investigation deals with the structural, morphology, electrical and dielectric properties of Cu-doped WO₃ nanoparticles with Cu content are varying from 5 to 15 wt% via the wet chemical method. The electrical properties of Cu influence WO₃ have also been investigated.

2. MATERIALS & METHODS

2.1 Chemicals

In this experiment, all chemicals were used analytically grade and without further purification. All the solutions were prepared in deionized water. Sodium tungstate dehydrate (Na₂WO₄·2H₂O), hydrochloric acid (HCl), Copper (II) chloride dihydrate (CuCl₂·2H₂O), PVP (C₆H₉NO)_n, CTAB((C₁₆H₃₃)N(CH₃)₃Br), oxalic acid (C₂H₂O₄·2H₂O) were used as precursors, dopant source, and solvent respectively.

2.2 Synthesis of WO₃ and Cu_xWO₃ Nanoparticles

The modified structures of tungsten trioxide nanoparticles doped with Cu were prepared by a wet chemical method. Initially, an appropriate amount of sodium tungstate dihydrate was dissolved in 20 ml of deionized water and stirred for 10-20 min. The solution was acidified to a pH value of 1.0 by slowly adding HCl under continuous stirring. A white precipitated solution was obtained, and it was added by oxalic acid. Then, the white precipitation solution was immediately changed to the transparent solution. After that, the transparent solution was changed to pale white color while adding CTAB. Upon introduction of PVP, the pale white color solution was changed into yellow color. Finally, 5, 10 and 15 wt% of copper (II) chloride dihydrate was dissolved in 10 ml of deionized water and then added to the resultant solution under magnetic stirring heated to 80°C for 1h, to ensure complete reaction. After the process was completed, resulting bluish-green precipitation were vigorously stirring for 24h at room temperature. To remove by-product, the obtained resultant precipitation was washed much time with ethanol, acetone and deionized water, filter and then dried in an oven at 180°C for 6h and to collect the as-prepared sample. Then dried products were annealed at 400°C in the muffle furnace. The color of bluish green as the prepared sample changed into the dark green sample during annealing. Hereafter, annealed copper doped tungsten oxide can be referred to as Cu_xWO₃ (x= 5, 10 and 15 wt%). A similar method of preparation without the addition of Cu was used to synthesize a pure WO₃ sample.

2.3 Material Characterization

The crystallographic information of Cu-doped WO₃ was obtained through X-ray diffraction (Bruker AXS D8 advance X-ray diffraction) and Field Emission Scanning Electron Microscope (FEI Quanta FEG-200) attached with energy dispersive spectrometer (EDX) at room temperature. DC electrical conductivity of pellet form of samples coated with silver paste on both surface was studied via a Keithley6517B. In addition, dielectric parameters and AC conductivity were obtained as a function of frequency (42Hz - 5MHz) at different temperatures using a computer-controlled-LCRHI Tester (HIOKI3532-50).

3. RESULTS AND DISCUSSION

3.1 Morphology and Structural Characterization

Fig. 1(a) shows XRD patterns of wet chemically synthesized 5, 10 and 15 wt% Cu-doped WO₃ together with pure WO₃. As shown in Fig 1a, several significant diffraction peaks (23.32°, 24.14°, 27.20°, 28.13°, 29.36°, 34.98°, 42.85° and 46.90°) could correspond to were observed for WO₃, characteristic of monoclinic WO₃ (JCPDS no. 72-1465). All Cu²⁺doped WO₃ exhibit some additional peaks at the angle 18.83° and 31.77° about 2θ corresponding to Cu₂WO₄ (indexed by *) phase, which was confirmed from JCPDS card no.78-0928. It was observed that, as the concentration of Cu²⁺doping increases, additional peak's intensity also increases. The presence of secondary Cu²⁺ phase in our samples confirms the limit of substitutional incorporation of Cu²⁺ ions into WO₃. The broadening of the peaks is responsible for the formation of particles in the nanometer regime (Hui Song *et al.* 2015). From Fig.1(b), it was noticed that the diffraction peaks shift slightly towards higher angles for all Cu²⁺ doping concentrations, which is due to the occupancy of W⁶⁺ (0.78 Å) sites by Cu²⁺(0.73Å), causing some kind of lattice distortion that is induced by the stress during the preparation (Jonscher, 1983). The crystallite size (D), calculated using Scherrer's formula:

$$D = \frac{0.89\lambda}{\beta \cos \theta} \quad (1)$$

where λ is the wavelength of incident X-ray, β is the full width at half maximum (FWHM) of the diffraction peak, and 2θ is diffraction angle. It can be noticed that the value of crystallite size increases with increasing Cu²⁺ doping are listed in Table 1. This may be due to lattice strain induced in the doped WO₃ caused by the small mismatch of ionic radii between the host W⁶⁺ and dopant Cu²⁺.

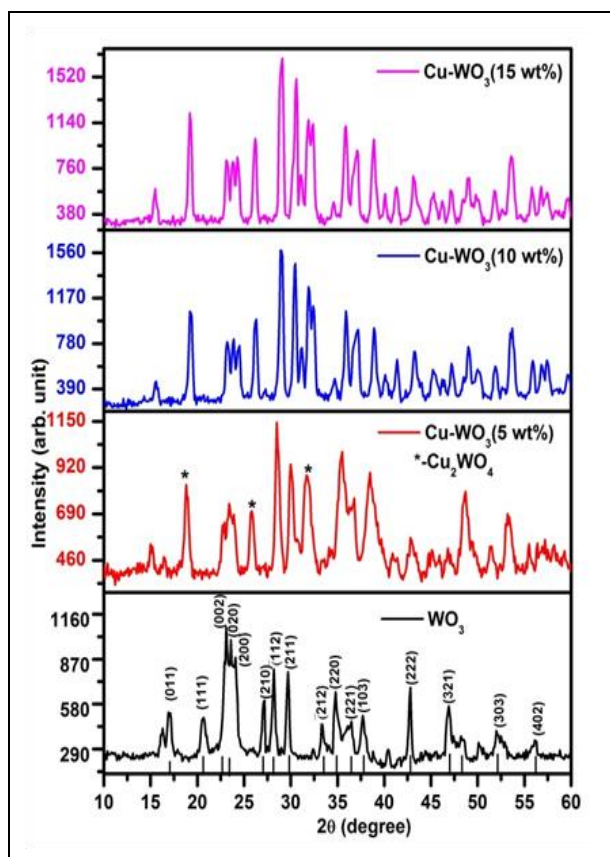


Fig. 1a: XRD of WO_3 and Cu doped WO_3 calcined at 400°C .

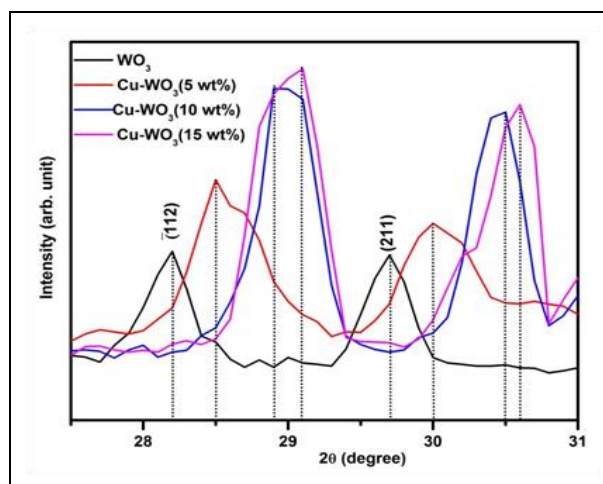


Fig. 1b: Comparison of the (221) and (112) peaks taken for WO_3 and Cu doped WO_3

The shifting of XRD peaks and corresponding to increase of crystallite size suggest that Cu^{2+} ions are successfully incorporated into the WO_3 without altering the overall crystal structure.

3.2 Microstructure and Compositional Studies

The FESEM measurements were carried out to confirm the nature of nanoparticles and to study the morphology of the particles. Fig. 2a–d shows the morphology of pure and Cu_xWO_3 nanoparticles ($x = 5, 10$ and 15 wt%) annealed at 400°C , respectively. The occurrence of particles is inhomogeneous and more compact structure. Also, the surface of the layer is covered with irregular distribution of particles structure.

Table 1. Summary of crystallite size and electrical conductivity of pure and copper doped WO_3

Samples	Crystallite size (β) (nm)	DC characterization			AC characterization		
		σ_{dc} (S/cm)	E_a (eV) 383-393 K	σ_{ac} (S/cm) at 1 MHz	E_a (eV) 383-393 K	Dielectric constant (ϵ')	Dielectric loss ($\tan \delta$)
Pure WO_3	15.57	9.04×10^{-8}	0.98	5.06×10^{-5}	0.55	2717	6.12
Cu- WO_3 (5 wt%)	16.67	3.49×10^{-7}	0.35	5.94×10^{-5}	0.34	359	4.18
Cu- WO_3 (10 wt%)	17.27	2.47×10^{-6}	0.34	2.54×10^{-5}	0.24	391	2.21
Cu- WO_3 (15 wt%)	18.81	1.29×10^{-5}	0.33	2.85×10^{-5}	0.42	480	2.83

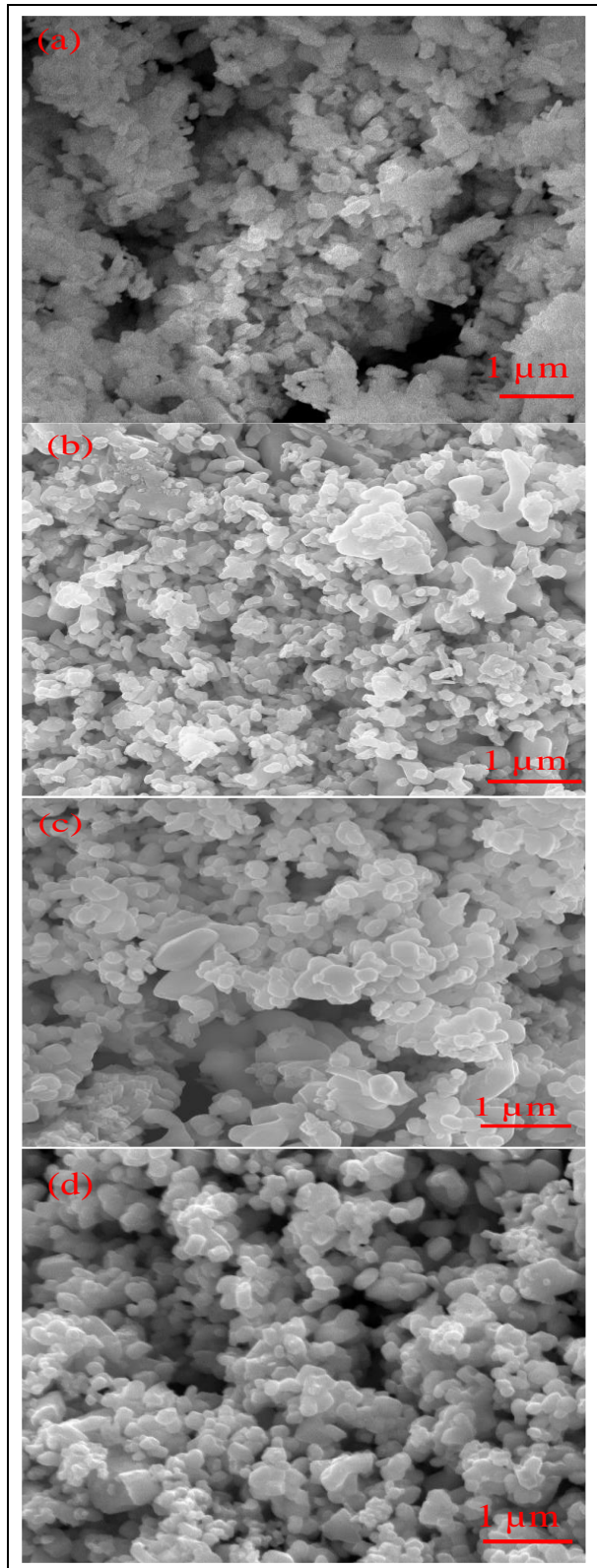


Fig. 2: FESEM image of (a) WO₃ (b) 5 wt% Cu doped WO₃ (c) 10 wt% Cu doped WO₃ and (d) 15 wt% Cu doped WO₃.

Fig. 2a shows the surface morphology of pure WO₃ nanoparticles, which has agglomerated irregular particle structure. The morphology of the Cu₅WO₃

sample is shown in Fig. 2b. It was observed that the irregular particles' structures disturbed by Cu-doping not altering the morphology of pure WO₃ nanoparticles. The further addition of 10 and 15 wt% of Cu into WO₃ improves the crystal structure quality of the samples, as shown in Fig. 2c-d. FESEM is revealed the formation of quasi-spherical nanoparticles with non-uniform particle size distribution. The presence of WO₃ phase and interstitials/vacancies made by Cu = 15 wt% sample particle size is higher than the sample with Cu = 5 wt% and 10 wt%. The quality of WO₃ sample is increased by increasing wt% of Cu. However, the appeared particle structure depends on the dopant concentration.

The presence of elements and purity of the samples is confirmed through EDX spectra. Fig. 3 the spectra indicate the atomic percentage of the compositional elements such as W, Cu, O and C, respectively. It proves the presence of Cu in WO₃ lattice.

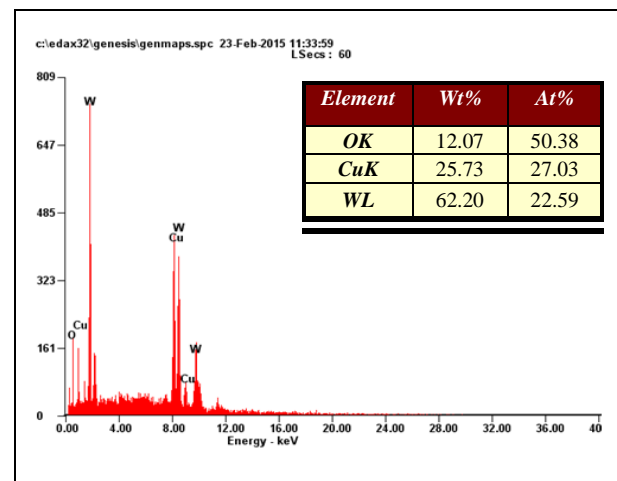


Fig. 3: EDAX spectra of 15 wt% Cu doped WO₃

3.3 Electrical Conductivity

The understanding of the conductivity represents the dynamic behaviour of ion in the conducting materials. The conductivity value at low-frequency spectra are frequency independent and are shown as DC conductivity. The temperature dependence of the dc conductivity gives information about the long time ion dynamics, and it is described by well known Arrhenius law, reflecting the activated nature of electron hopping processes. At high frequencies, the conductivity becomes strongly frequency-dependent. The total measured conductivity (σ_T), is related to the DC conductivity σ_{dc} , and the component σ_{ac} of the materials was first reported by Jonscher power law (Jonscher, 1983) as

$$\sigma_T = \sigma_{ac} + \sigma_{dc} = A\omega^s \quad (2)$$

where σ_{dc} is DC conductivity is frequency independent, A is a constant, s is the exponent of frequency ($s < 1$), and ω is the angular frequency of the applied field ($\omega = 2\pi f$). The above equation explains the measured AC conductivity σ_T increases by 3–4 orders of magnitude of DC conductivity (σ_{dc}). Hence, the measured value of total conductivity σ_T has depended on the typical values of AC conductivity. The real part of AC conductivity obeys the following relation:

$$\sigma_{ac} = \varepsilon_0 \omega \varepsilon' \tan \delta \quad (3)$$

where $\varepsilon' = \frac{Cd}{\varepsilon_0 A} \tan \delta = \frac{\varepsilon''}{\varepsilon'}$ and, defines dielectric constant and loss tangent, ε_0 is the free space permittivity, and A is an area of the pellet, and d is the thickness of pellet samples. The value of $\tan \delta$ is depended on the frequency, temperature and composition of the sample.

3.3.1 DC electrical conductivity (σ_{dc})

WO₃ is a well-known n-type semiconductor. The electrical conductivity is linked with tungsten interstitials and oxygen vacancy (intrinsic defects) present in WO₃. These defects introduce donor states in the forbidden band slightly below the conduction band, thus resulting in the conducting behavior of WO₃. The electrical conductivity of the sample is controlled by the intrinsic defects generated during synthesis and by the presence of dopant. Simpson and Cordero (Simpson and Cordaro, 1988) have reported electrical conductivity of the sample at room temperature is caused by oxygen vacancy. Thus, the electrical conductivity (σ_{dc}) of the pure and wt% of copper doped WO₃ for different temperatures in the range 303–403 K with an increment of 10 K has been calculated by the formula:

$$\sigma = \frac{1}{\rho} = \frac{VA}{Id} \quad (4)$$

where V is the applied voltage, I is the measured current, A is the pellet area, and d is the pellet thickness. Fig.4a reveals that the electrical conductivity has been found to increase with the increase of temperature for both pure and doped WO₃, and the values lie in the order of 10⁻⁸–10⁻⁵ S cm⁻¹. i.e., indicating a semiconducting nature of all the samples. At higher temperature region, the carrier concentration increases due to intrinsic thermal excitation and electron emission. At lower temperatures, the probability of thermal excitation becomes quickly smaller so that the charge carrier hops to a neighbouring localized state (Gartstein and Conwell, 1995). The electrical conductivity of WO₃ is increased with an increase in Cu concentration. This can be explained on the basis of a smaller conductivity of copper (5.8 × 10⁵ Ωcm) than that of (1.79 × 10⁵ Ωcm).

The temperature dependence of conductivity can be represented by the well-known Arrhenius equation, given by

$$\sigma_{dc} = \sigma_0 \exp\left[\frac{-E_a}{RT}\right] \quad (5)$$

where σ_0 is the pre-exponential factor, E_a is the thermal activation energy, R is the ideal gas constant, and T is the temperature in Kelvin.

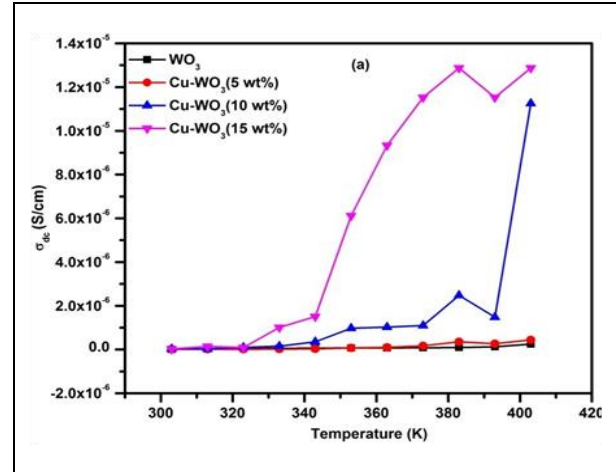


Fig. 4a: Temperature-dependent DC electrical conductivity of WO₃ and Cu doped WO₃

Fig. 4b shows the plots of the $\ln \sigma_{dc}$ versus $10^3/T$ (K⁻¹) for pure and doped WO₃. The activation energy has been calculated using the slope of this figure for each sample. Activation energy has been found to decrease with an increase of copper content presented in Table 1. When WO₃ is doped with Cu, then Cu atoms replace W atoms which can be easily ionized because of the smaller ionization potential of Cu than that of W. Therefore, the DC electrical conductivity of WO₃ is increased by increasing Cu doping and the corresponding decrease in activation energy is found to be associated with a shift of Fermi level in doped samples (Shumaila et al. 2011). Another attempt has also been made to confirm the nature of hopping conduction and observe the strength of the interaction of electron-phonon. We have fitted temperature dependence resistivity data with the small polaron hopping model given by Mott and Davis (Mott and Davis, 1979). It is also found that high-temperature transport properties in the rare-earth transition metal oxide systems are dominated by the thermally activated hopping of small polaron. The increase in temperature causes the electrons to acquire enough energy and cross or trapped adjacent atoms or ions site. Thus, in the high-temperature region, the electrical conductivity of pure and Cu-doped WO₃ is thermally activated from the donor level to the conduction band due to the small polaron hopping process.

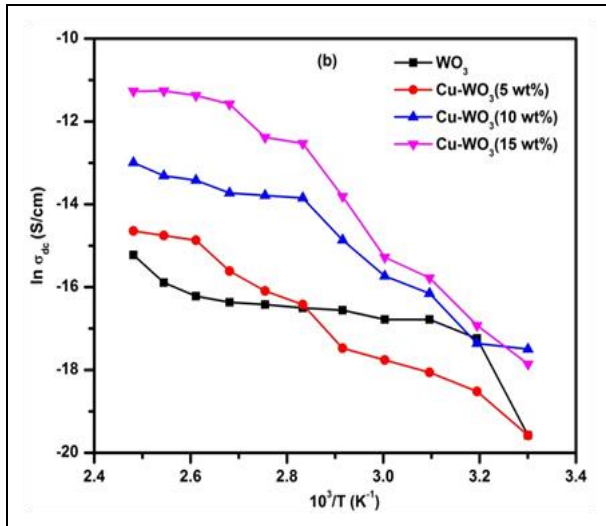


Fig. 4b: Arrhenius plot $\ln\sigma_{ac}$ versus T^{-1} for WO_3 and Cu doped WO_3

3.3.2 AC conductivity (σ_{ac})

The measurement of frequency dependence of AC conductivity is providing information about the nature of charge carriers. The relation between the AC conductivity and the frequency at different temperature for the pure and doped WO_3 under investigation is plotted as $\ln f$ versus σ_{ac} . The frequency-dependent of AC conductivity value is weak at lower frequencies, and then it increases rapidly at higher frequencies. Therefore, the electrical conduction in the sample takes place via a hopping mechanism. It is also clear from Fig. 5a-5d that the maximum conductivity is obtained for pure WO_3 , which decreases with increasing wt% of Cu doping in WO_3 . This decrease in AC conductivity can be explained by the fact that Cu ions produce defects such as oxygen vacancies and tungsten interstitials in the WO_3 host system. These defects tend to segregate at the grain boundaries. Therefore, the defects increased by increasing Cu doping which facilitates the formation of defect barrier in the grain boundary leading to the blockage of the flow of charge carriers. This, in turn, decreases the conductivity of WO_3 on doping. The values of AC activation energies (E_a) obtained for the samples from the slope of σ_{ac} versus $10^3/T$ at the frequency of 1MHz as illustrated in Fig. 6. The increase of applied field frequency enhances the electronic jumps between localized states, and consequently, the activation energy E_a decreases, which confirms the hopping conduction between the defect centers around Fermi level to be a dominant mechanism of conduction. This means that σ_{ac} at high frequencies is not thermally activated in a relatively wide range of temperatures. On the other hand, at lower frequencies and higher temperatures, the AC conductivity is temperature dependent, similar to that of DC conductivity. The activation energy is found to decrease while the conductivity increases with an increase in Cu content.

Since the conductivity is associated with an increase in the concentration of mobile electrons or polarons, indicating an increase in the concentration of Cu^{2+} in the samples.

The frequency exponent (s) was obtained by the slope of the linear part of $\ln f$ versus σ_{ac} plots for the present $Cu_{15}WO_3$ samples as shown in Fig. 5e inset to Fig. 5d. The value of exponent (s) lies between 0 and 1, depending on temperature and materials. Thus, this independent of frequency and gives us information about the conduction mechanism for charge carriers in the materials. It was found to decrease from 0.817 to 0.145 with increasing temperature. This behaviour was associated with the correlated barrier hopping (CBH) model (Hutchins *et al.* 2007). In the CBH model, bipolaron has been proposed to interpret the frequency-dependent conductivity. This model does not explain the conductivity of samples at the high-temperature region, particularly in the low-frequency range. Therefore, CBH model can be used to describe temperature-dependent AC conductivity of the present samples at low-temperature region.

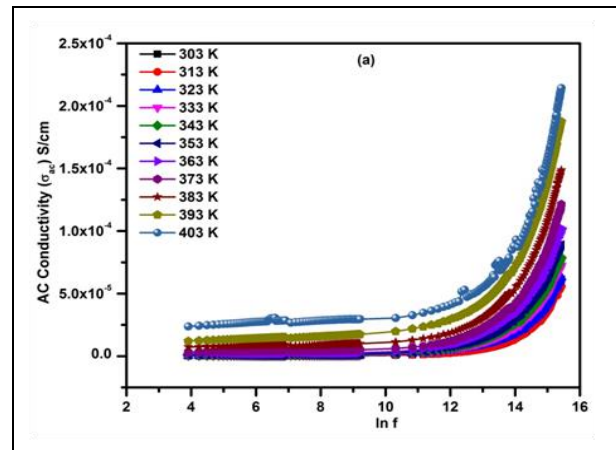


Fig. 5a: Frequency dependence of AC conductivity (σ_{ac}) for WO_3

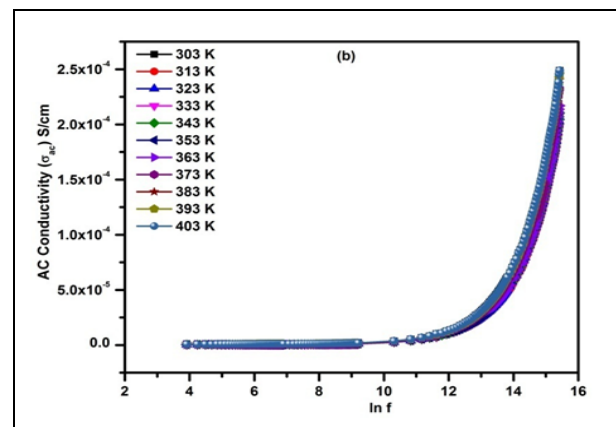


Fig. 5b: Frequency dependence of AC conductivity (σ_{ac}) for 5 wt % Cu doped WO_3

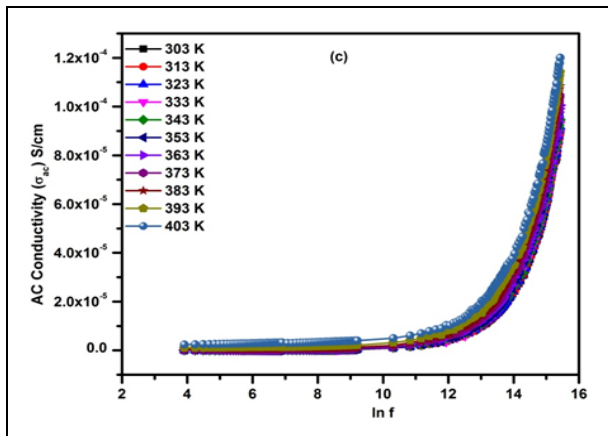


Fig. 5c: Frequency dependence of AC conductivity (σ_{ac}) for 10 wt % Cu doped WO_3

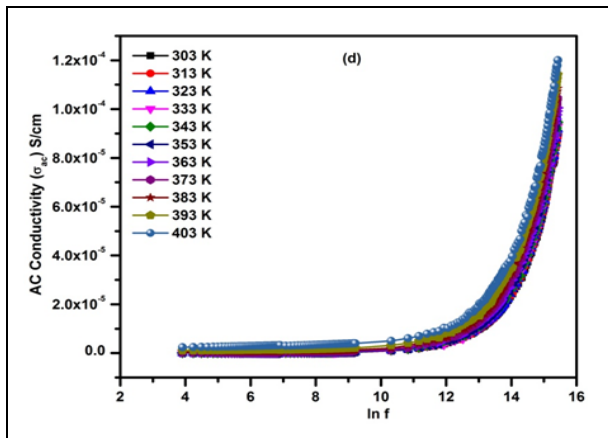


Fig. 5d: Frequency dependence of AC conductivity (σ_{ac}) for 15 wt% Cu doped WO_3 at different temperature. Inset: Variation of frequency exponent (s) with a temperature of 15 wt% Cu doped WO_3

3.3.3 Dielectric constant (ϵ') and dielectric loss ($\tan \delta$)

The dielectric constant (ϵ') of pure and doped WO_3 as a function of frequency in the range from 42Hz to 5MHz at various temperatures (303-403 K) is shown in Fig. 7. The value of the dielectric constant was found to increase with increasing temperature and at a higher temperature; it reaches maximum value, especially at lower frequencies for both the samples. Further, the higher dielectric constant value at lower frequencies, it decreases with increase in frequency and thereafter becomes constant at a very high frequency for all temperature. This type of behavior is in agreement with M–W (Maxwell–Wagner) model. In this model, a dielectric medium is composed of well-conducting grains, which are separated by poorly conducting and resistive grain boundaries. Therefore, an electric field is applied externally; the charge carriers can easily move within the grain and get accumulated at the grain boundaries as a result of large polarization and high dielectric constant produced in the sample (Wagner *et al.*

1913). The small conductivity at grain boundary contributes to the higher dielectric constant value at a low-frequency region. Additionally, the higher value of the dielectric constant can be explained on the basis of space charge/interfacial polarization, which occurs due to inhomogeneity of dielectric structure. In the present sample, the dopant Cu creates defects such as vacancies, porosities, the presence of oxygen etc. Meanwhile, Gupta *et al.* also found that the average grain size also played a crucial role in the dielectric constant (Gupta and Kumar, 2011). When average grain size decreases, the number of grain per unit volume increases. Hence, the number of electric dipoles per unit volume in the dielectric medium also increases, which increases the dielectric constant of the material. The smaller crystallite size of pure WO_3 has the maximum dielectric constant among doped samples. The dopant Cu is responsible for the dielectric constant value in the present samples. The dielectric constant decreases with the increase in frequency and then reach a constant value due to the fact that beyond a certain frequency of external field, the hopping between different metal ions (W^{5+} , Cu^{2+}) cannot follow the alternating field. The reduction of dielectric constant with frequency is natural because of the fact that any species contributing to polarizability is found to show lagging behind the alternating applied field at higher and higher (Reza Zamiriet *al.* 2014).

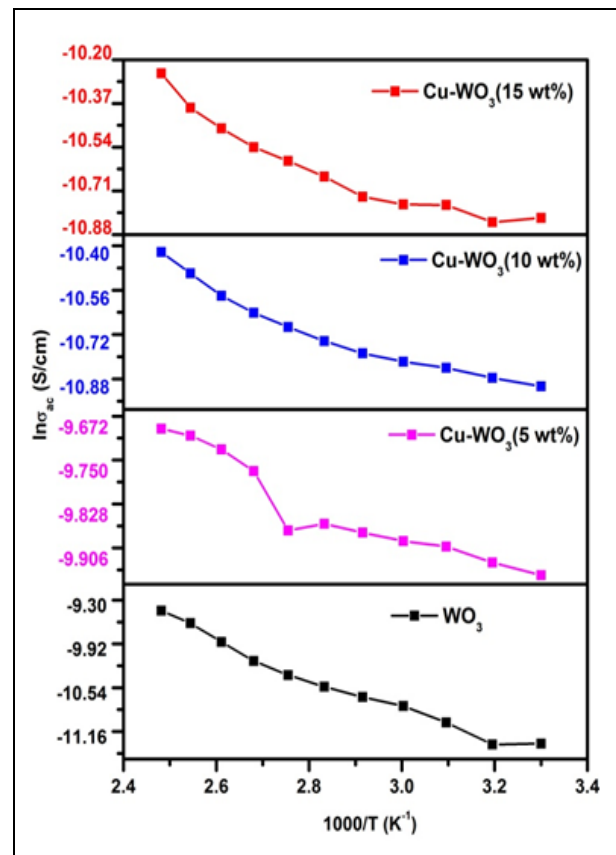


Fig. 6: Arrhenius plot $\ln\sigma_{ac}$ versus $T^{-1/3}$ for WO_3 and Cu doped WO_3

3.3.3 Dielectric constant (ϵ') and dielectric loss ($\tan \delta$)

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Fig. 8 reveals that the value of dielectric loss ($\tan \delta$) is found to increase with the increase in temperature, especially at higher temperatures and at lower frequencies. The dielectric loss represents the dissipation of energy in the dielectric system. The $\tan \delta$ values decrease with the increase of frequency and become almost frequency constant and independent at higher frequencies for all the samples, which may be due to space charge polarization. On the other hand, $\tan \delta$ curves exhibit a peaking behavior for WO_3 . The observed new

peaks at lower temperatures were observed and also noted that the height of the peak increases as the temperature increases. The observed peaks of $\tan \delta$ versus frequency graphs can be explained according to the fact that a strong correlation between the conduction mechanism and the dielectric behavior exists in the sample.

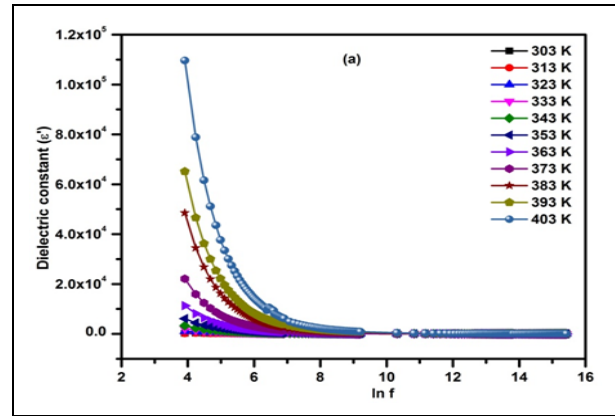


Fig. 7a: Frequency dependence of dielectric constant (ϵ') for WO_3

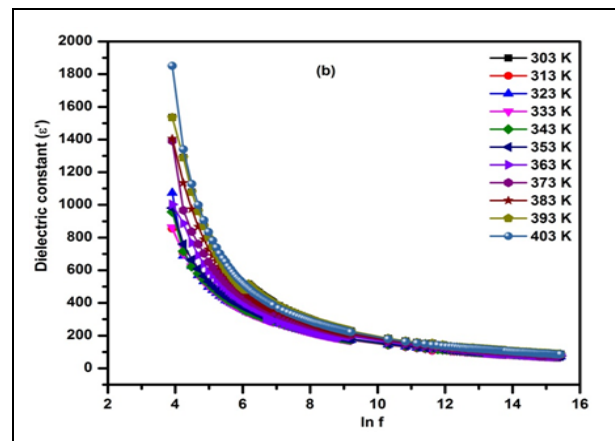


Fig. 7b: Frequency dependence of dielectric constant (ϵ') for 5 wt% Cu doped WO_3

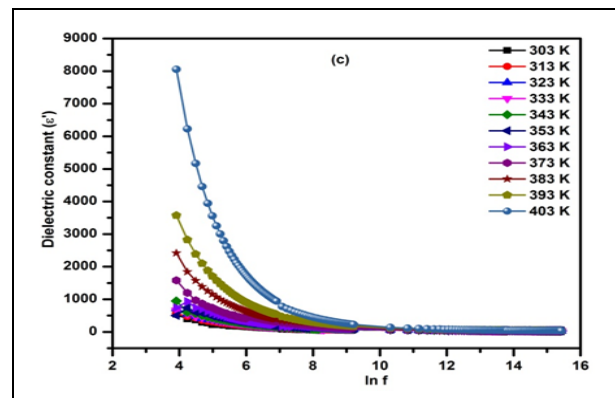


Fig. 7c: Frequency dependence of dielectric constant (ϵ') for 10 wt% Cu doped WO_3

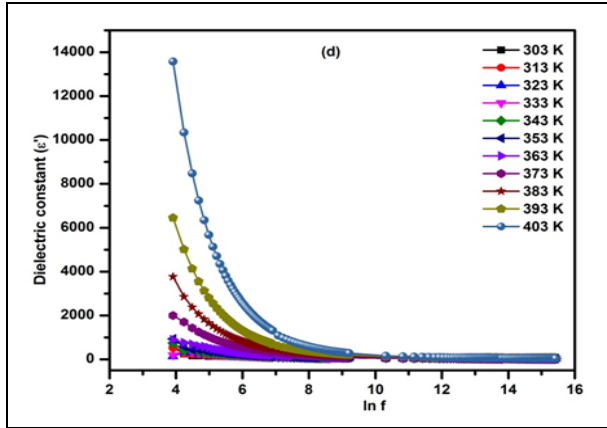


Fig. 7d: Frequency dependence of dielectric constant (ϵ') for 15 wt% Cu doped WO_3 at different temperature.

Therefore, a peak is expected when the hopping frequency of the electrons hopping between W^{5+} and W^{6+} ions is approximately equal to that of the externally applied field. Additionally, the observed peak of the pure WO_3 sample has been maximum exhibit loss which decreases after Cu doping and is gradual decreases in the higher frequency regime.

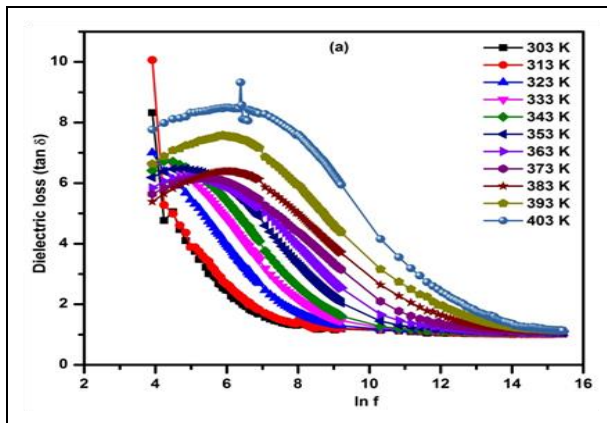


Fig. 8a: Frequency dependence of dielectric loss ($\tan \delta$) for WO_3

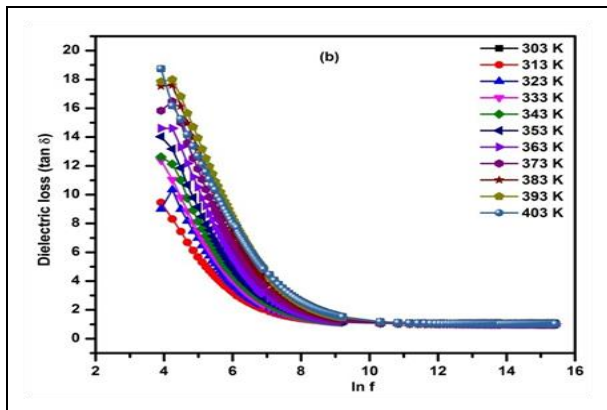


Fig. 8b: Frequency dependence of dielectric loss ($\tan \delta$) for 5 wt% Cu doped WO_3

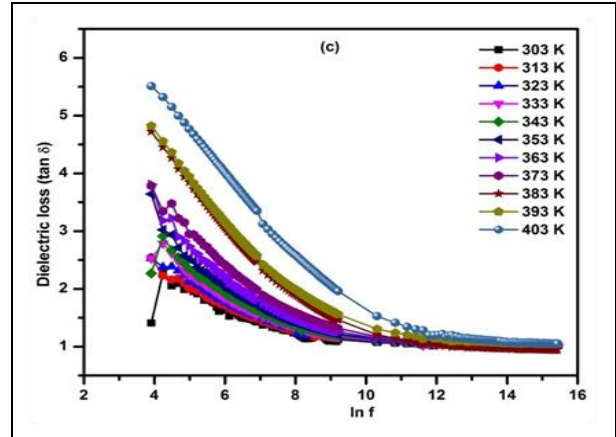


Fig. 8c: Frequency dependence of dielectric loss ($\tan \delta$) for 10 wt% Cu doped WO_3

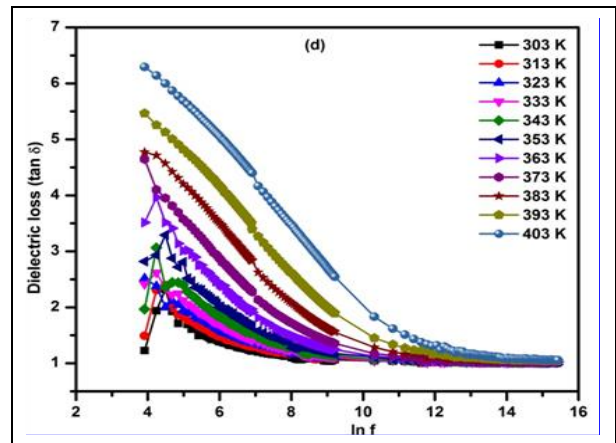


Fig. 8d: Frequency dependence of dielectric loss ($\tan \delta$) for 15 wt% Cu doped WO_3 at different temperature

The measured σ_{ac} , ϵ' and $\tan \delta$ increase as Cu^{2+} ion substitution increases as a function of frequency at various temperature. The number of vacancies may be established at the tungsten site as Cu content increases. Such vacancies start on the thermal dissociation of oxygen, which in turn increases the number of electrons (Zaki, 2005). It will be helpful to increase the hopping process and can account for the increase in σ_{ac} , ϵ' and $\tan \delta$ as Cu content increases. For that reason, it can be concluded that the Cu-doped WO_3 can be applied for high-frequency device applications.

4. CONCLUSION

In summary, Cu-doped WO_3 nanoparticles have been successfully synthesized by the wet chemical method. The structural and morphological studies revealed the presence of Cu^{2+} had been completely incorporated in the WO_3 . The small polaron hopping is observed in DC conductivity. The temperature of electrical conductivity was found to be thermally activated within 303-403 K. The electrical conductivity obeys Arrhenius behavior, and plot exposed activation

energies decreased with increasing wt% of Cu content indicates a thermally activated process. The calculated frequency exponent (s) is found to be less than one and decreased with the increase of temperature; consequently, the correlated barrier hopping (CBH) model is the most probable conduction mechanism for both the pure and Cu doped WO_3 . AC conductivity of WO_3 nanoparticles is found to decrease with Cu doping. This reduction in conductivity could be due to the presence of tungsten interstitials and oxygen vacancies in WO_3 on Cu doping. Therefore, the incorporation of Cu ions in WO_3 lattice facilitates the formation of grain boundary defect leading to the blockage of the flow of charge carriers. This, in turn, decreases the conductivity of the system on doping. The frequency dependence of the dielectric study of the prepared samples showed the dielectric constant and dielectric loss at different temperature due to wt% of Cu-dopant. From the observation, the simple and low-cost fabrication of Cu-doped WO_3 nanoparticles and its interesting electrical and dielectric properties of the material used to make nanoelectronic devices such as a capacitor, gas sensing, humidity sensing, absorption, etc.

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CONFLICTS OF INTEREST

The authors declare that there is no conflict of interest.

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